

Notice of References Cited	Application/Control No. 10/574,917		Applicant(s)/Patent Under Reexamination FENG ET AL.	
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	U	Guo et al., Chin Med J 119(6):662-668, 2006.
	V	Shimamura et al., Cir 109:424-431, 2004.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.